

Notice of References Cited.	Application/Control No. 10/722,880		Applicant(s)/Patent Under Reexamination PARULSKI ET AL.	
	Examiner Richard M. Bemben		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,910,147	06-2005	Needham, Bradford H	713/502
*	B	US-2004/0036774	02-2004	Nichols et al.	348/207.1
*	C	US-2002/0135685	09-2002	Tsunoda, Naoki	348/231.2
*	D	US-7,158,171	01-2007	Ichihara, Shintaro	348/207.2
*	E	US-2005/0057658	03-2005	Ohmura et al.	348/207.99
*	F	US-6,728,880	04-2004	Sites, Richard L.	713/178
*	G	US-5,500,897	03-1996	Hartman, Jr., Robert C.	713/178
*	H	US-6,393,126	05-2002	van der Kaay et al.	380/241
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.